Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,806	LAI ET AL.
Examiner	Art Unit
David E. Martinez	2181

	SEARCHED		
Class	Subclass	Date	Examiner
710	52,53,57	3/3/2006	DM
		-	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East see attached	3/3/2006	DM ·
Inventor search eDan	3/3/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, Derwent, IBM_TDB.	3/3/2006	DM